

Normally – OFF Silicon Carbide Junction Transistor

V _{DS}	=	600 V
V _{DS(ON)}	=	1.3 V
I _D	=	20 A
R _{DS(ON)}	=	65 mΩ

Features

- 250 °C maximum operating temperature
- Temperature independent switching performance
- Electrically isolated base-plate
- Gate oxide free SiC switch
- Suitable for connecting an anti-parallel diode
- · Positive temperature coefficient for easy paralleling
- · Low gate charge
- Low intrinsic capacitance

Advantages

- Low switching losses
- · Higher efficiency
- High temperature operation
- · High short circuit withstand capability

Package

RoHS Compliant





TO - 257 (Isolated Base-plate Hermetic Package)

Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- · Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

Maximum Ratings at T_i = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Drain – Source Voltage	V_{DS}	V _{GS} = 0 V	600	V
Continuous Drain Current	I _D	145 °C < T _C < 160 °C	20	Α
Gate Peak Current	I _{GM}		5	Α
Turn-Off Safe Operating Area	RBSOA	T_{VJ} = 250 °C, I_{G} = 1 A, Clamped Inductive Load	$I_{D,max} = 20$ $\emptyset V_{DS} \le V_{DSmax}$	Α
Short Circuit Safe Operating Area	SCSOA	T_{VJ} = 250 °C, I_{G} = 2.5 A, V_{DS} = 400 V, Non Repetitive	20	μs
Reverse Gate – Source Voltage	V _{GS}	·	30	V
Reverse Drain – Source Voltage	V _{DS}		40	V
Power Dissipation	P _{tot}	T _C = 25 °C	22	W
Operating and Storage Temperature	T_{j}, T_{stg}		-55 to 250	°C

Electrical Characteristics at T_i = 250 °C, unless otherwise specified

Parameter	O. mala al	Complete Conditions	Values			
	Symbol	Conditions	min.	typ.	max.	Unit
On Characteristics						
Drain – Source On Voltage	$V_{DS(ON)}$	$\begin{split} I_D &= 20 \text{ A, } I_G = 400 \text{ mA, } T_J = 25 \text{ °C} \\ I_D &= 20 \text{ A, } I_G = 500 \text{ mA, } T_J = 125 \text{ °C} \\ I_D &= 20 \text{ A, } I_G = 1000 \text{ mA, } T_J = 175 \text{ °C} \\ I_D &= 20 \text{ A, } I_G = 1000 \text{ mA, } T_J = 250 \text{ °C} \end{split}$		1.3 1.8 2.2 3.3		V
Drain – Source On Resistance	R _{DS(ON)}	$\begin{split} &I_D = 20 \text{ A, } I_G = 400 \text{ mA, } T_J = 25 \text{ °C} \\ &I_D = 20 \text{ A, } I_G = 500 \text{ mA, } T_J = 125 \text{ °C} \\ &I_D = 20 \text{ A, } I_G = 1000 \text{ mA, } T_J = 175 \text{ °C} \\ &I_D = 20 \text{ A, } I_G = 1000 \text{ mA, } T_J = 250 \text{ °C} \end{split}$		65 91 110 165		mΩ
Gate Forward Voltage	$V_{GS(FWD)}$	I _G = 1000 mA, T _j = 25 °C I _G = 1000 mA, T _j = 250 °C		3.0 2.7		٧
DC Current Gain	β	$\begin{array}{c} V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{j} = 25 \text{ °C} \\ V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{j} = 125 \text{ °C} \\ V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{j} = 175 \text{ °C} \\ V_{DS} = 5 \text{ V, } I_{D} = 20 \text{ A, } T_{j} = 250 \text{ °C} \\ \end{array}$		110 78 73 69		



Off Characteristics

		$V_R = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25 \text{ °C}$	10	
Drain Leakage Current	I_{DSS}	$V_R = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 175 ^{\circ}\text{C}$	50	μA
		$V_R = 600 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 250 \text{ °C}$	100	
Gate Leakage Current	I _{sg}	$V_{SG} = 20 \text{ V}, T_j = 25 ^{\circ}\text{C}$	20	nA

Electrical Characteristics at T_j = 250 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values		Unit		
	Зушьог	Conditions	min.	typ.	max.	————	
Capacitance Characteristics							
Gate-Source Capacitance	C_{gs}	$V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		2400		pF	
Input Capacitance	C_{iss}	$V_{GS} = 0 \text{ V}, V_{D} = 1 \text{ V}, f = 1 \text{ MHz}$		3700		pF	
Reverse Transfer/Output Capacitance	C_{rss}/C_{oss}	$V_D = 1 V, f = 1 MHz$		840		pF	

Switching Characteristics

Turn On Delay Time	$t_{d(on)}$		92	ns
Rise Time	t _r		42	ns
Turn Off Delay Time	$t_{\sf d(off)}$	$V_{DD} = 400 \text{ V}, I_D = 20 \text{ A},$	51	ns
Fall Time	t _f	V_{GS} = -8/15 V , T_j = 175 °C Refer to Figure 15 for gate drive	31	ns
Turn-On Energy Per Pulse	E _{on}	current waveforms	811	μJ
Turn-Off Energy Per Pulse	E_{off}		96	μJ
Total Switching Energy	E_{ts}		907	μJ
Turn On Delay Time	$t_{d(on)}$		91	ns
Rise Time	t _r		17	ns
Turn Off Delay Time	$t_{\sf d(off)}$	$V_{DD} = 400 \text{ V}, I_D = 20 \text{ A},$	50	ns
Fall Time	t _f	V _{GS} = -8/15 V ,T _j = 250 °C Refer to Figure 15 for gate drive current waveforms	21	ns
Turn-On Energy Per Pulse	E _{on}		100	μJ
Turn-Off Energy Per Pulse	E_{off}		40	μJ
Total Switching Energy	E _{ts}		140	μJ

Thermal Characteristics

Thermal Onalacteristics			
Thermal resistance, junction - case	R_{thJC}	1.16	°C/W

Figures

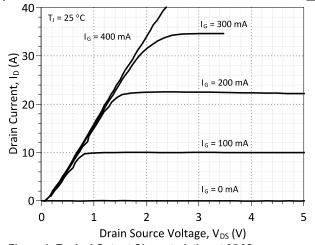


Figure 1: Typical Output Characteristics at 25 °C

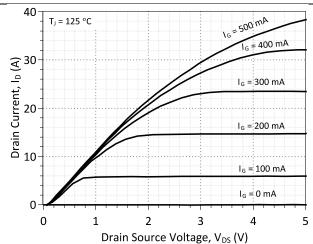


Figure 2: Typical Output Characteristics at 125 °C



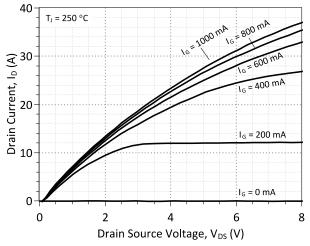


Figure 3: Typical Output Characteristics at 250 °C

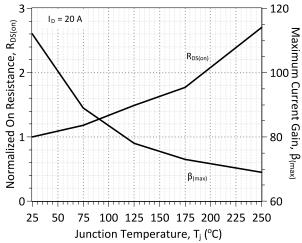


Figure 5: Normalized On-Resistance and Current Gain vs. Temperature

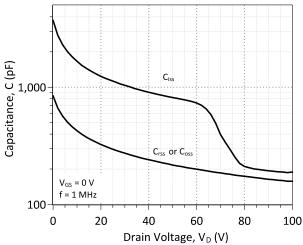


Figure 7: Capacitance Characteristics

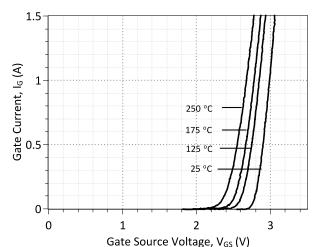


Figure 4: Typical Gate Source I-V Characteristics vs.
Temperature

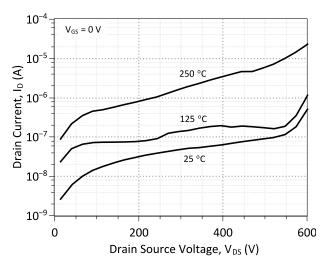


Figure 6: Typical Blocking Characteristics

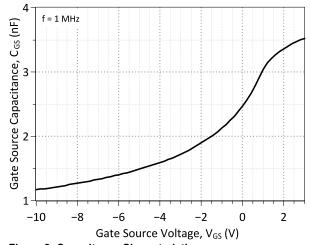


Figure 8: Capacitance Characteristics



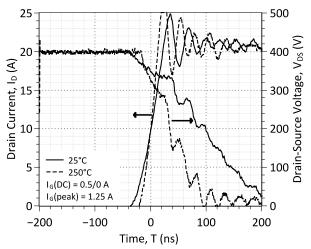


Figure 9: Typical Hard-switched Turn On Waveforms

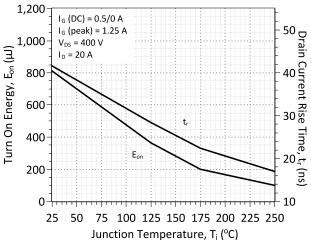


Figure 11: Typical Turn On Energy Losses and Switching Times vs. Temperature

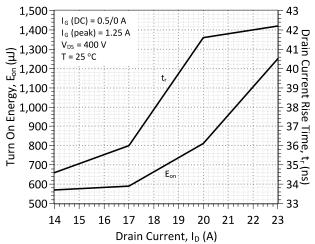


Figure 13: Typical Turn On Energy Losses vs. Drain Current

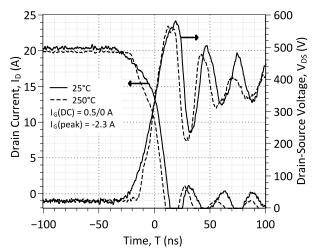


Figure 10: Typical Hard-switched Turn Off Waveforms

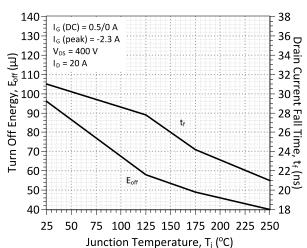


Figure 12: Typical Turn Off Energy Losses and Switching Times vs. Temperature

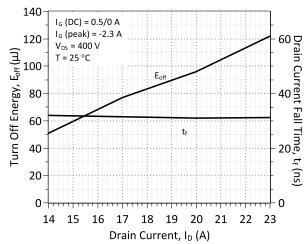


Figure 14: Typical Turn Off Energy Losses vs. Drain Current



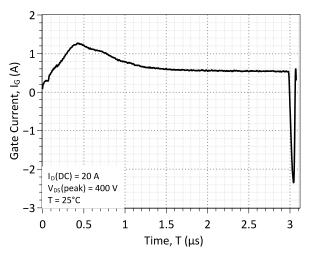


Figure 15: Typical Gate Current Waveform

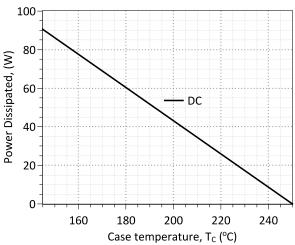


Figure 17: Power Derating Curve

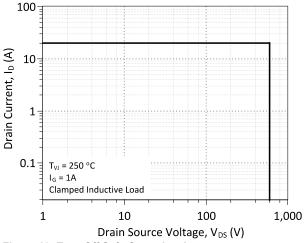


Figure 19: Turn-Off Safe Operating Area

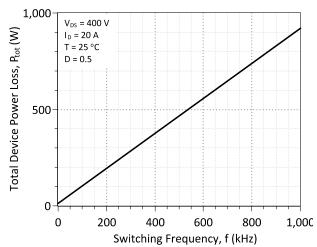


Figure 16: Typical Hard Switched Device Power Loss vs. Switching Frequency ¹

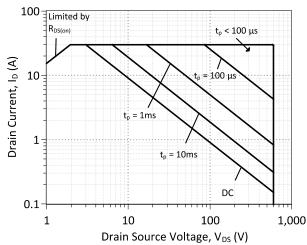


Figure 18: Forward Bias Safe Operating Area at $T_c \text{=} 145\ ^{\circ}\text{C}$

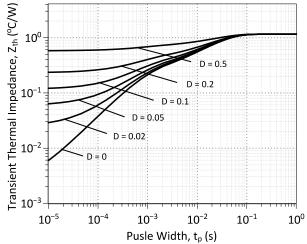


Figure 20: Transient Thermal Impedance

¹ – Representative values based on device switching energy loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.



Gate Drive Technique (Option #1)

To drive the 2N7639-GA with the lowest gate drive losses, please refer to the dual voltage source gate drive configuration described in Application Note AN-10B (http://www.genesicsemi.com/index.php/references/notes).

Gate Drive Technique (Option #2)

The 2N7639-GA can be effectively driven using the IXYS IXDN614 / IXDD614 non-inverting gate driver IC **or a comparable product**. A typical gate driver configuration along with component values using this driver is offered below. Additional information is available in GeneSiC Application Note AN-10A and from the manufacturer at www.ixys.com.

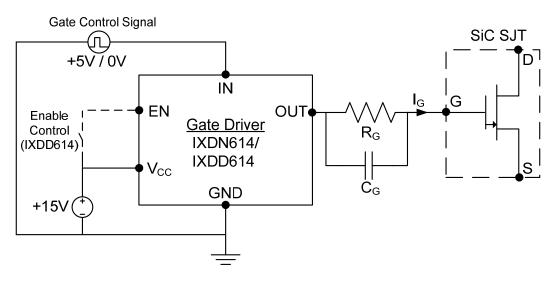
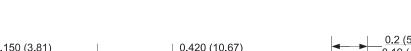


Figure 21: Recommended Gate Diver Configuration (Option #2)

Dozemster	Cumbal	Conditions	Values			
Parameter	Symbol		min.	typ.	max.	Uni
Option #1 Gate Drive Conditions (IX	(DD614/IXDN614)					
Supply Voltage, High Side Driver	V _{CC}	V_{GH}	15	20	30	V
Supply Voltage, Low Side Driver	V _{cc}	V_{GL}	5	6.5		V
Off State Voltage, Both Drivers	GND	V _{EE}		-10	0	V
Gate Control Input Signal, Low	IN		-5.0	0	0.8	V
Gate Control Input Signal, High	IN		4	5.0	V _{CC} +0.3	V
Enable, Low	EN	IXDD614 Only			1/3*V _{CC}	V
Enable, High	EN	IXDD614 Only	2/3*V _{CC}			V
Output Voltage, Low	V_{OUT}				0.025	V
Output Voltage, High	V_{OUT}		V _{CC} -0.025			V
Output Current, Peak	I _{OUT}	Package Limited			14	Α
Output Current, Continuous	I _{OUT}			0.5	4.0	Α
Passive Gate Components						
Gate Resistance	R_{G}	$V_{GL} = 6.0 \text{ V}, I_{G} \approx 0.5 \text{ A}$		1.6	5	Ω
Gate Capacitance	C_G	$V_{GH} = 20 \text{ V}, I_{G,pk} \approx 4.0 \text{ A}$	20	35		nF

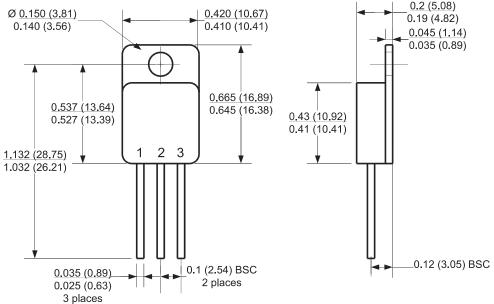


Package Dimensions:



PACKAGE OUTLINE

TO-257



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date	Revision	Comments	Supersedes			
2013/12/09	2	Updated Electrical Characteristics				
2013/11/18	1	Updated Electrical Characteristics				
2012/08/24	0	Initial release				

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the 2N7639-GA device.

```
MODEL OF GeneSiC Semiconductor Inc.
     $Revision: 1.0
     $Date: 06-SEP-2013
    GeneSiC Semiconductor Inc.
     43670 Trade Center Place Ste. 155
    Dulles, VA 20166
    http://www.genesicsemi.com/index.php/hit-sic/sjt
    COPYRIGHT (C) 2013 GeneSiC Semiconductor Inc.
     ALL RIGHTS RESERVED
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
.model 2N7639-GA NPN
+ IS
       6.03E-47
+ ISE
          1.72E-28
+ EG
          3.23
+ BF
         122
+ BR
         0.55
         300
+ IKF
+ NF
         1.868
+ NE
+ RB
         0.26
+ RE
         0.088
         0.01
+ RC
         5.68E-10
+ CJC
+ VJC
         2.978967839
+ MJC
          0.466424924
+ CJE
         1.72E-09
+ VJE
         2.77859888
+ MJE
        0.48415
+ XTI
         3
          -0.78
+ XTB
          7.00E-02
+ TRC1
+ VCEO
         600
+ ICRATING 20
+ MFG GeneSiC Semiconductor
```

* End of 2N7639-GA SPICE Model